

Form 1449 (Modified)

**Information Disclosure
Statement By Applicant**

(Use Several Sheets if Necessary)

Atty Docket No.:

IMM1P069D

Applicant:

Schuler et al.

Filing Date:

8/14/00

Application No.:

09/638,485

Group:

2837

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
TS	A	4,937,685	6/26/90	Barker et al.	360-	14.1	12/2/83
TS	B	4,964,004	10/16/90	Barker	360	14.1	6/16/89
TS	C	4,0983,901	1/8/91	Lehmer	318	685	4/21/89
TS	D	5,076,517	12/31/91	Ferranti et al.	244	228	8/14/89
TS	E	5,184,319	2/2/93	Kramer	364	806	2/2/90
TS	F	5,286,203	2/15/94	Fuller et al.	434	45	10/7/92
TS	G	5,354,162	10/11/94	Burdea et al.	414	5	8/31/92
TS	H	5,428,748	6/27/95	Davidson et al.	395	275	9/24/92
TS	I	5,634,794	6/3/97	Hildreth et al.	434	37	3/23/95
TS	J	5,742,278	4/21/98	Chen et al.	345	156	11/1/95
TS	K	5,781,172	7/14/98	Engel et al.	345	164	6/16/97

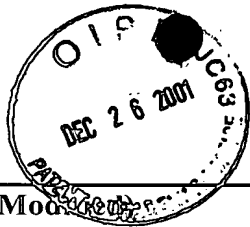
Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	0085518	10.08.83	EPO			X	
TS	M	0111992	27.06.84	EPO			X	
TS	N	0349086	03.01.90	EPO			X	
TS	O	2235310	27.02.91	GB			X	
TS	P	0326439	2.8.89	EPO				

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
TS	R	Flight Simulation, Rolfe, J.M. and Staples, K. J., eds., 1986.
	S	
	T	
Examiner <i>Deane Smith</i>		Date Considered <i>5/13/02</i>

Examiner Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
TS	A	5,999,168	12/7/99	Rosenberg et al.	345	161	2/21/97
TS	B	6,088,017	7/11/00	Tremblay et al.	345	156	4/24/98
	C						
	D						
	E						
	F						
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	J						
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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	95/20788	3.8.95	PCT			X	
TS	M	0626634	30.11.94	EPO			X	
TS	N	H6-210065	2.8.94	Japan			X	
TS	O	H4-92691	25.3.92	Japan			X	
TS	P	H5-86387	22.11.93	Japan			X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
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Examiner <i>Deanne Smith</i>	Date Considered 5/13/02	

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	J						
	K						

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	S62-194389	10.12.87	Japan			X	
TS	M	0607580 -	27.7.94	EPO			X	
TS	N	92/00559 -	9.1.92	PCT			X	
TS	O	JP4092691	25.3.92	Japan			X	
TS	P	JP7024147 -	27.1.95	Japan			X	

Other Documents

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	A						
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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	JP4008381	13.1.92	Japan			X	
	M							
	N							
	O							
	P							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
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Examiner <i>Draw Smith</i>	Date Considered <i>5/13/02</i>	

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